Search Notes								
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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/813,915	SWIFT ET AL.	
Examiner	Art Unit	
Steven S. Paik	2876	

SEARCHED						
Class	Subclass	Date	Examiner			
235	379	1/18/2006	SSP			
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INTERFERENCE SEARCHED					
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SEARCH NO (INCLUDING SEARCH)
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Test search 235/380;381;382;383;449;487;493 705/42;43;44	1/18/2006	SSP.